Список литературы

- [1] Baldi, M, Corno, F, Rebaudengo, M, Reorda, M. S, & Squillero, G. (2000), eds. Corne, D, Smith, G, & Oates, M. J. (Wiley).
- [2] Corno, F, Reorda, M. S, & Squillero, G. (2000) Rt-level itc 99 benchmarks and first atpg results. pp. 44–53.
- [3] Corno, F, Prinetto, P, Rebaudengo, M, Reorda, M. S, & Squillero, G. (2002) Initializability analysis of synchronous sequential circuits.
- [4] Corno, F, Prinetto, P, Rebaudengo, M, Reorda, M. S, & Squillero, G. (1997) A New Approach for Initialization Sequences Computation for Synchronous Sequential Circuits. pp. 381–386.
- [5] Corno, F, Prinetto, P, Rebaudengo, M, Reorda, M. S, & Squillero, G. (1997) A Genetic Algorithm for the Computation of Initialization Sequences for Synchronous Sequential Circuits. pp. 56–61.
- [6] Baldi, M, Corno, F, Rebaudengo, M, Prinetto, P, Reorda, M. S, & Squillero, G. (1997) Simulation-Based Verification of Network Protocols Performance. pp. 236–251.
- [7] Baldi, M, Corno, F, Rebaudengo, M, & Squillero, G. (1997) GA-based Performance Analysis of Network Protocols. pp. 118–124.
- [8] Corno, F, Reorda, M. S, & Squillero, G. (1998) The Selfish Gene Algorithm: a New Evolutionary Optimization Strategy. pp. 349–355.
- [9] Corno, F, Reorda, M. S, & Squillero, G. (1998) A New Evolutionary Algorithm Inspired by the Selfish Gene Theory. pp. 575–580.
- [10] Corno, F, Reorda, M. S, & Squillero, G. (1998) VEGA: A Verification Tool Based on Genetic Algorithms. pp. 321–326.
- [11] Corno, F, Reorda, M. S, & Squillero, G. (1999) Approximate Equivalence Verification of Sequential Circuits via Genetic Algorithms.
- [12] Corno, F, Reorda, M. S, & Squillero, G. (1999) Approximate Equivalence Verification for Protocol Interface Implementation via Genetic Algorithms. pp. 182–192.
- [13] Corno, F, Reorda, M. S, & Squillero, G. (1999) Optimizing Deceptive Functions with the SG-Clans Algorithm. pp. 2190–2195.
- [14] Corno, F, Reorda, M. S, & Squillero, G. (1999) Verifying the Equivalence of Sequential Circuits with Genetic Algorithms. pp. 1293–1297.
- [15] Corno, F, Reorda, M. S, & Squillero, G. (1999) Simulation-Based Sequential Equivalence Checking of RTL VHDL. pp. 351–354.
- [16] Corno, F, Reorda, M. S, & Squillero, G. (1999) High Quality Test Pattern Generation for RT-level VHDL Descriptions.
- [17] Corno, F, Manzone, A, Pincetti, A, Reorda, M. S, & Squillero, G. (2000) Automatic Test Bench Generation for Validation of RT-level Descriptions: an Industrial Experience. pp. 385–389.
- [18] Corno, F, Reorda, M. S, & Squillero, G. (2000) Automatic Validation of Protocol Interfaces Described in VHDL. pp. 205–213.
- [19] Corno, F, Rebaudengo, M, Reorda, M. S, Squillero, G, & Violante, M. (2000) Prediction of Power Requirements for High-Speed Circuits. pp. 247–254.
- [20] Corno, F, Reorda, M. S, & Squillero, G. (2000) Evolving Cellular Automata for Self-Testing Hardware. pp. 31–39.
- [21] Corno, F, Reorda, M. S, & Squillero, G. (2000) High-Level Observability for Effective High-Level ATPG. pp. 411–416.

- [22] Corno, F, Rebaudengo, M, Reorda, M. S, Squillero, G, & Violante, M. (2000) Low Power BIST via Hybrid Cellular Automata. pp. 29–34.
- [23] Corno, F, Reorda, M. S, Squillero, G, & Violante, M. (2000) CA-CSTP: A new BIST Architecture for Sequential Circuits. pp. 167–172.
- [24] Corno, F, Reorda, M. S, & Squillero, G. (2000) An Improved Cellular Automata-Based BIST Architecture for Sequential Circuits. pp. 76–79.
- [25] Corno, F, Reorda, M. S, & Squillero, G. (2000) Exploiting the Selfish Gene Algorithm for Evolving Hardware Cellular Automata. pp. 1401–1406.
- [26] Corno, F, Reorda, M. S, & Squillero, G. (2000) Exploiting the Selfish Gene Algorithm for Evolving Cellular Automata.
- [27] Corno, F, Reorda, M. S, Squillero, G, & Violante, M. (2000) A Genetic Algorithm-based System for Generating Test Programs for Microprocessor IP Cores.
- [28] Corno, F, Reorda, M. S, & Squillero, G. (2001) Evolving Effective CA/CSTP BIST Architectures for Sequential Circuits.
- [29] Corno, F, Reorda, M. S, Squillero, G, & Violante, M. (2001) On the Test of Microprocessor IP Cores. pp. 209–213.
- [30] Corno, F, Cumani, G, Reorda, M. S, & Squillero, G. (2001) ARPIA: a High-Level Evolutionary Test Signal Generator.
- [31] Corno, F, Cumani, G, Reorda, M. S, & Squillero, G. (2001) Effective Techniques for High-Level ATPG.
- [32] Corno, F, Cumani, G, Reorda, M. S, & Squillero, G. (2001) Devising an RT-Level ATPG for uProcessor Cores.
- [33] Corno, F, Reorda, M. S, & Squillero, G. (2002) An Evolutionary Algorithm for Reducing Integrated-Circuit Test Application Time. pp. 608–611.
- [34] Corno, F, Cumani, G, Reorda, M. S, & Squillero, G. (2002) Automatic Test Program Generation from RT-level microprocessor descriptions.
- [35] Corno, F, Reorda, M. S, & Squillero, G. (2002) Evolutionary Techniques for Minimizing Test Signals Application Time.
- [36] Corno, F, Cumani, G, Reorda, M. S, & Squillero, G. (2002) Efficient Machine-Code Test-Program Induction.